

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10626787	LEEK, WILLIAM F.
	<b>Examiner</b>	<b>Art Unit</b>
	PHI D A	3633

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
52	295, 293.3, 296, 223.1, 223.13, 223.14, 298, 702, 714	9/25/08	pa
411	231, 432, 917	9/25/08	
74	441, 409	9/25/08	
267	172, 170	9/25/08	

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
SEE ATTACHED	9/25/08	PA

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
ALL THE SEARCHED SUBCLASSE S		9/25/08	PA

--	--